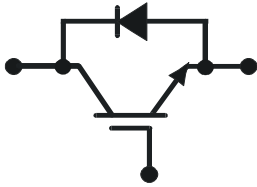


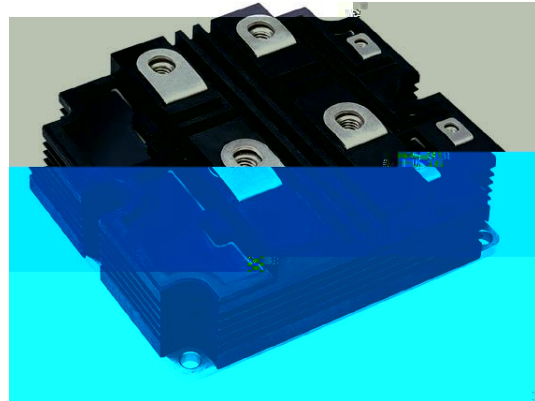
$V_{CE} = 6500 \text{ V}$

$I_C = 400 \text{ A}$



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- Low-loss, rugged SPT chip-set
- Smooth switching SPT chip-set for good EMC
- High insulation package
- AISiC base-plate for high power cycling capability
- AlN substrate for low thermal resistance



Maximum rated values ¹⁾

Parameter	Symbol	Conditions	min	max	Unit
Collector-emitter voltage	V_{CES}	$V_{GE} = 0 \text{ V}, T_{vj} \geq 25 \text{ °C}$		6500	V
DC collector current	I_C	$T_c = 85 \text{ °C}$		400	A
Peak collector current	I_{CM}	$t_p = 1 \text{ ms}, T_c = 85 \text{ °C}$		800	A
Gate-emitter voltage	V_{GES}		-20	20	V
Total power dissipation	P_{tot}	$T_c = 25 \text{ °C}$, per switch (IGBT)		7350	W
DC forward current	I_F			400	A
Peak forward current	I_{FRM}			800	A
Surge current	I_{FSM}	$V_R = 0 \text{ V}, T_{vj} = 125 \text{ °C}$, $t_p = 10 \text{ ms}$, half-sinewave		4000	A
IGBT short circuit SOA	t_{psc}	$V_{CC} = 4400 \text{ V}, V_{CEMCHIP} \leq 6500 \text{ V}$ $V_{GE} \leq 15 \text{ V}, T_{vj} \leq 125 \text{ °C}$		10	μs
Isolation voltage	V_{isol}	1 min, $f = 50 \text{ Hz}$		10200	V
Junction temperature	T_{vj}				

(at) T35.2 0 TD () Tj2Tc ((e

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IGBT characteristic values ³⁾

Parameter	Symbol	Conditions	min	typ	max	Unit
Collector (-emitter) breakdown voltage	$V_{(BR)CES}$	$V_{GE} = 0 \text{ V}, I_C = 10 \text{ mA}, T_{vj} = 0 \text{ °C}$	224	240	240	V

Diode characteristic values ⁵⁾

Parameter	Symbol	Conditions	min	typ	max	Unit	
Forward voltage ⁶⁾	V_F	$I_F = 400 \text{ A}$	$T_{vj} = 25 \text{ °C}$		3.2	3.8	V
			$T_{vj} = 125 \text{ °C}$		3.4	4.0	
Reverse recovery current	I_{rr}	$V_{CC} = 3600 \text{ V},$ $I_F = 400 \text{ A},$ $V_{GE} = \pm 15 \text{ V},$ $R_G = 5.6 \text{ } \Omega$ $L_\sigma = 280 \text{ nH}$ inductive load	$T_{vj} = 25 \text{ °C}$		510		A
			$T_{vj} = 125 \text{ °C}$		680		
Recovered charge	Q_{rr}		$T_{vj} = 25 \text{ °C}$		450		μC
			$T_{vj} = 125 \text{ °C}$		770		
Reverse recovery time	t_{rr}		$T_{vj} = 25 \text{ °C}$		1840		ns
			$T_{vj} = 125 \text{ °C}$		2120		
Reverse recovery energy	E_{rec}	$T_{vj} = 25 \text{ °C}$		670		mJ	
		$T_{vj} = 125 \text{ °C}$		1380			

⁵⁾ Characteristic values according to IEC 60747 – 2

⁶⁾ Forward voltage is given at chip level

Package properties ⁷⁾

Parameter	Symbol	Conditions	min	typ	max	Unit
IGBT thermal resistance junction to case	$R_{th(j-c)IGBT}$				0.016	K/W
Diode thermal resistance junction to case	$R_{th(j-c)DIODE}$				0.032	K/W
IGBT thermal resistance ²⁾ case to heatsink	$R_{th(c-s)IGBT}$	IGBT per switch, λ grease = 1W/m^2	0.0			

Electrical configuration C (3)G (2)

○



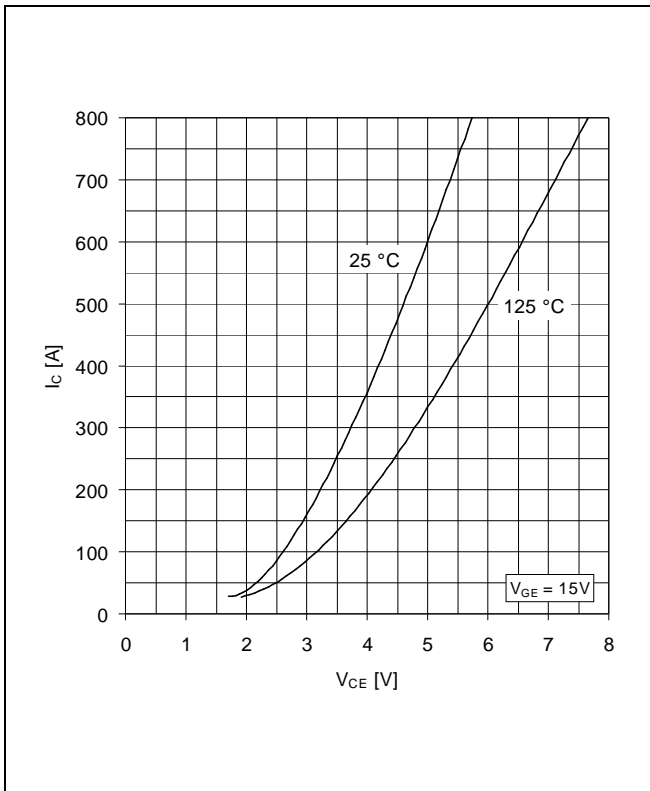


Fig. 1 Typical on-state characteristics, chip level

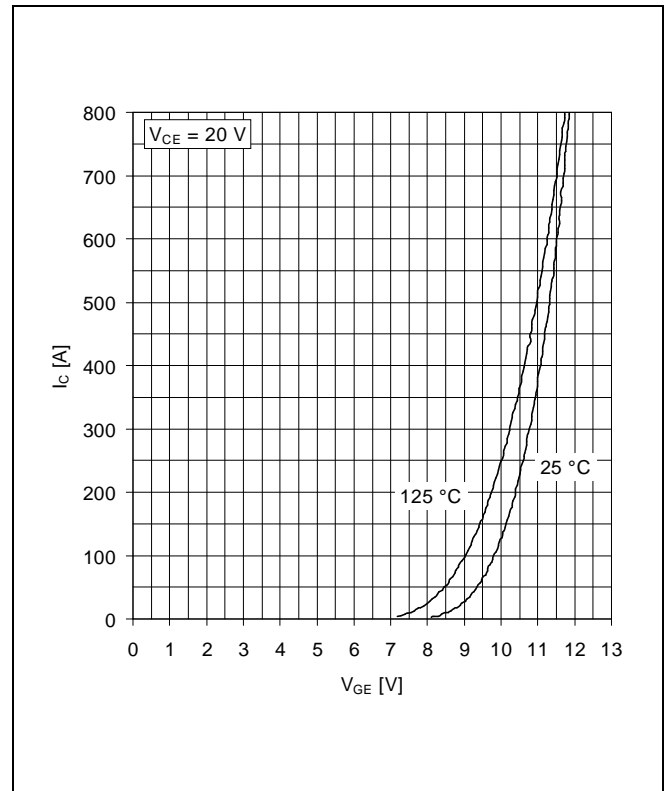
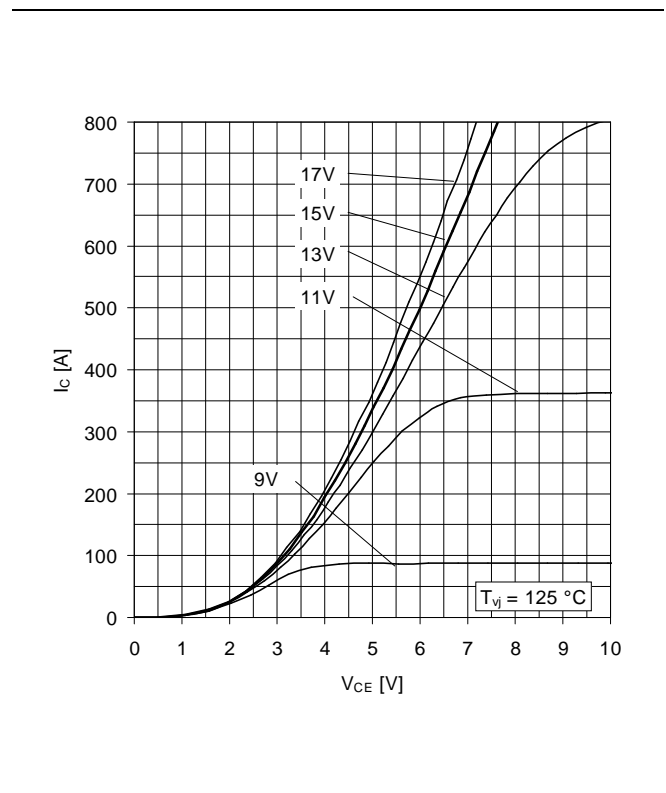
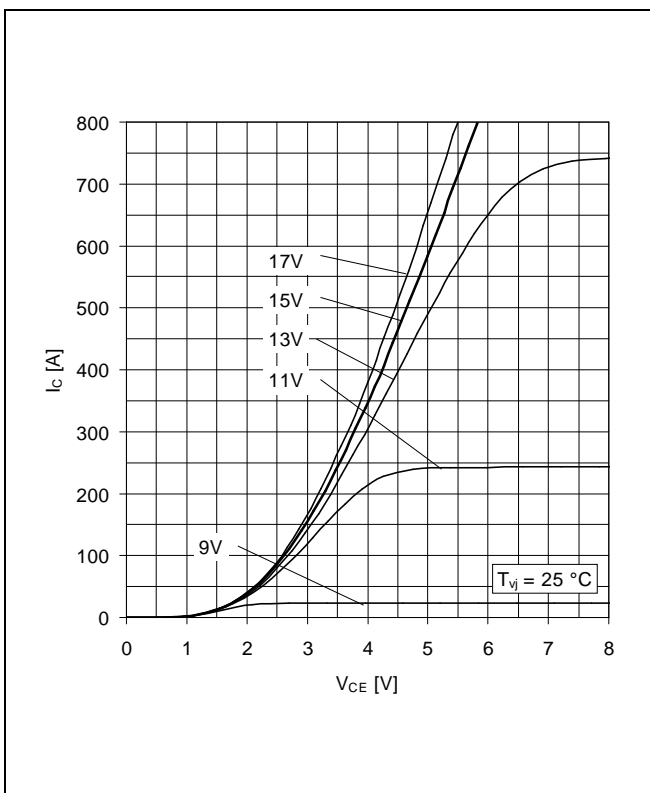
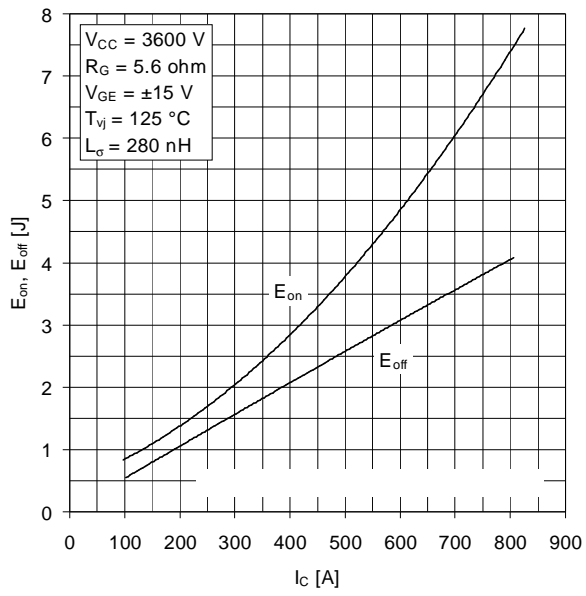


Fig. 2 Typical transfer characteristics, chip level





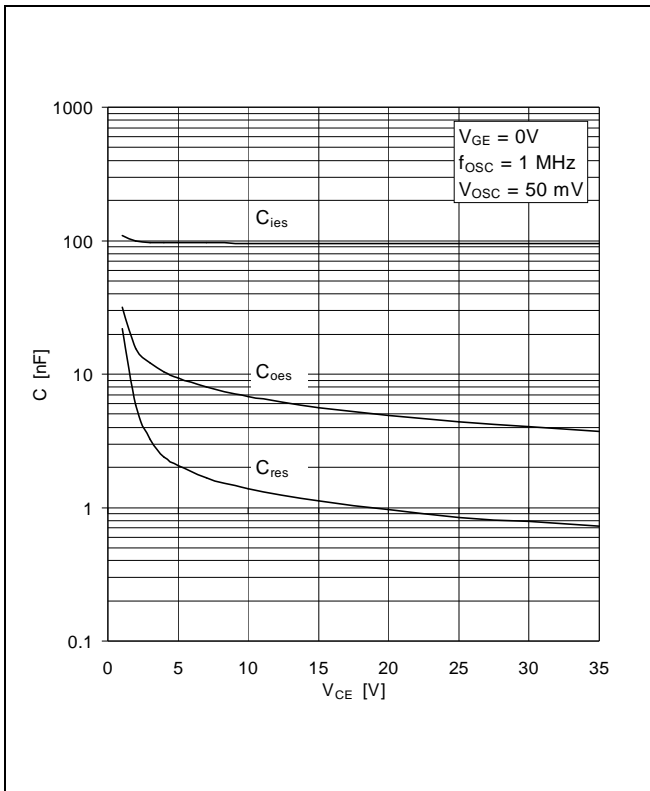


Fig. 9 Typical capacitances vs collector-emitter voltage

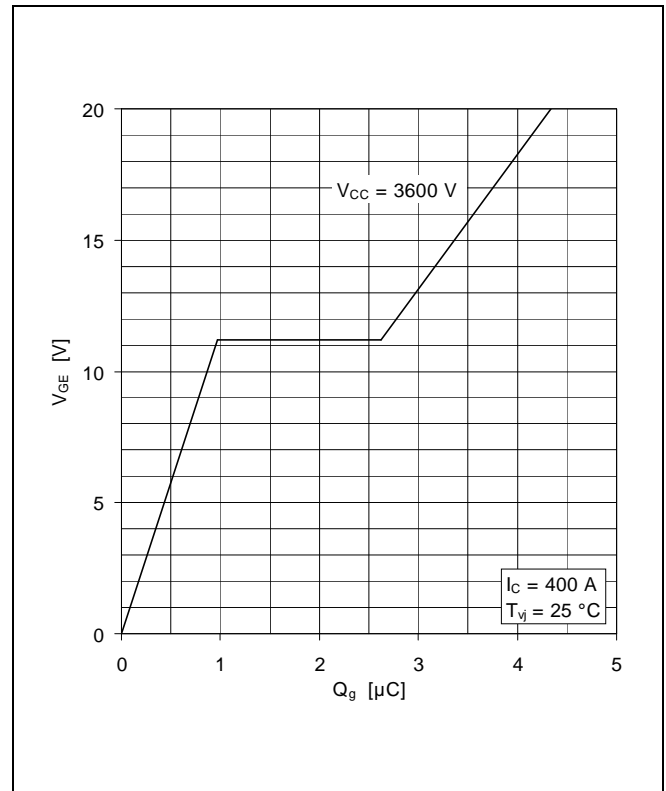


Fig. 10 Typical gate charge characteristics

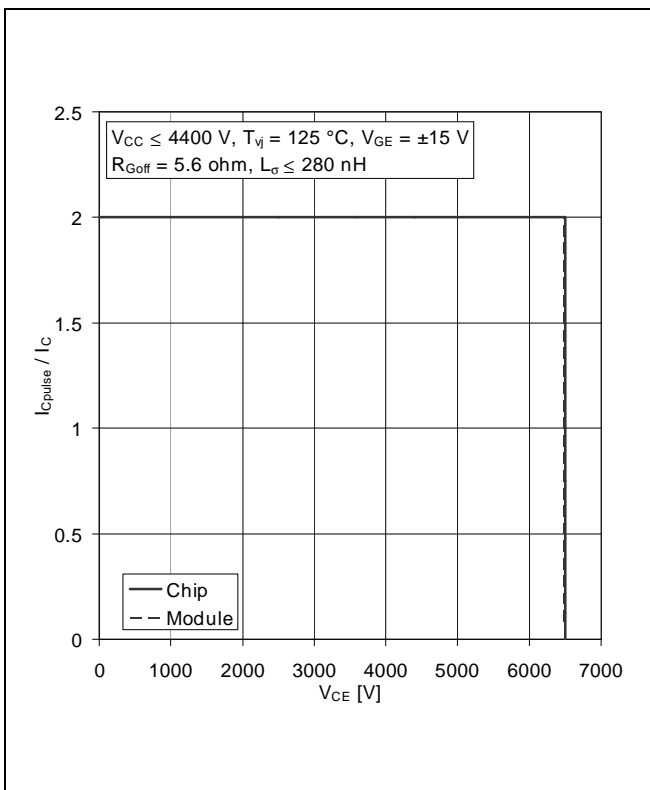
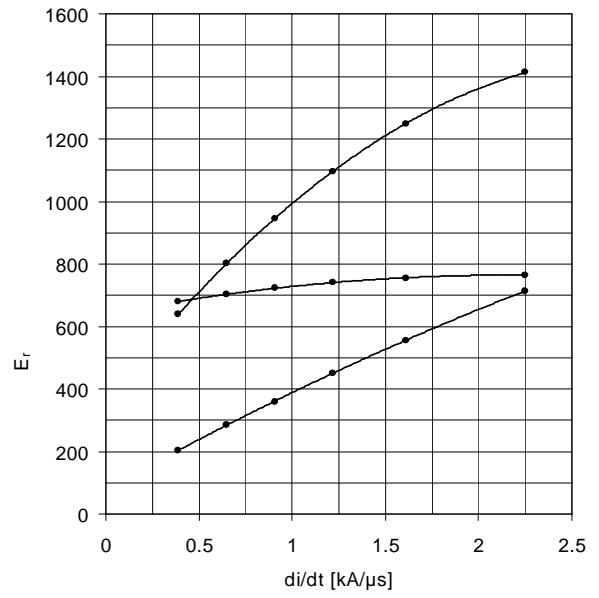
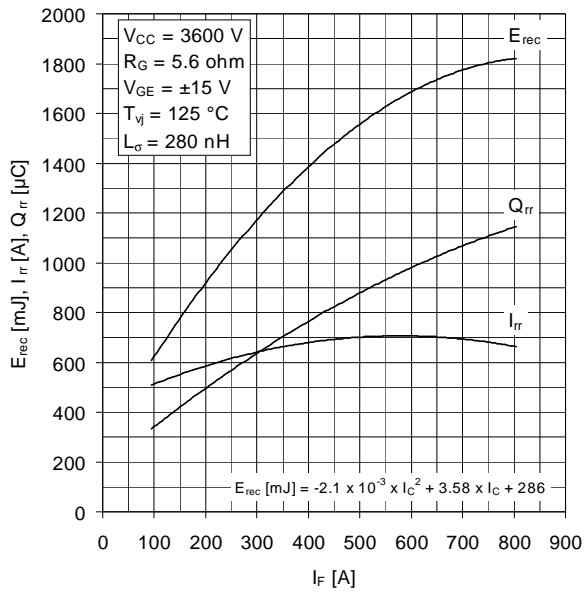


Fig. 11 Turn-off safe operating area (RBSOA)



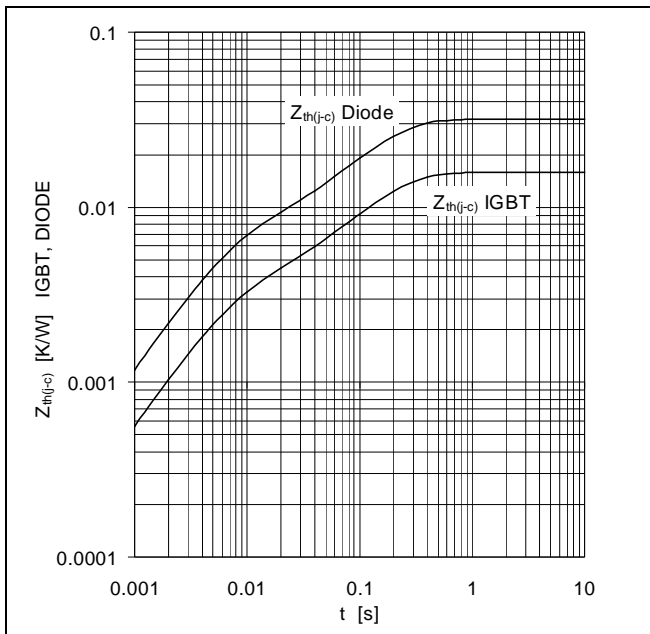


Fig. 16 Thermal impedance vs time

Analytical function for transient thermal impedance:

$$Z_{th(j-c)}(t) = \sum_{i=1}^n R_i (1 - e^{-t/t_i})$$

	i	1	2	3	4	5
IGBT	R_i (K/kW)	12.75	2.99			
	τ_i (ms)	151	5.84			
DIODE	R_i (K/kW)	25.5	6.3			
	τ_i (ms)	144	5.83			

For detailed information refer to:

- 5SYA 2042 Failure rates of HiPak modules due to cosmic rays
- 5SYA 2043 Load – cycle capability of HiPaks
- 5SYA 2045 Thermal runaway during blocking
- 5SYA 2058 Surge currents for IGBT diodes
- 5SZK 9120 Specification of environmental class for HiPak

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ABB Switzerland Ltd
Semiconductors
 Fabrikstrasse 3
 CH-5600 Lenzburg, Switzerland

Doc. No. 5SYA 1592-02 Jan 09

Telephone +41 (0)58 586 1419
 Fax +41 (0)58 586 1306
 Email abbsem@ch.abb.com
 Internet www.abb.com/semiconductors